

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/605,172	WAKEFIELD, IVAN N.	
		Examiner	Art Unit	Page 1 of 1
		TUAN H. LE	2622	

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*	B	US-2004/0208372	10-2004	Boncyk et al.	382/181
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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